

Search Notes

Application/Control No.

10/658,275

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under
Reexamination

HICKEY ET AL.

Art Unit

1745

SEARCHED

Class	Subclass	Date	Examiner
429	12	3/8/2006	DWY
429	30	3/8/2006	DWY
429	46	3/8/2006	DWY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/8/2006	DWY
STN	3/8/2006	DWY